Enhancing the temperature sensitivity of Cr³⁺ emissions by modification of the host composition for fluorescent thermometry applications

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Phosphor	GdAB	YAB	LuAB	(Lu _{0.6} Al _{0.4})AB					
Space group		R 32							
a (Å)	9.3072	9.2879	9.2691	9.2690					
b (Å)	9.3072	9.2879	9.2691	9.2690					
c (Å)	7.2658	7.2406	7.2083	7.2080					
V (Å ³)	545.07	540.93	536.35	536.31					
Rwp (%)	5.13	9.36	9.80	11.2					
Rp (%)	3.64	7.78	7.82	9.63					

 Table S1 Refined crystallographic data of LnAB:0.12Cr³⁺

 Table S2 Al-O bond lengths in LnAB:0.12Cr³⁺

Phosphor	Al-O1	Al-Ol	Al-O2	Al-O2	Al-O3	Al-O3	Average
	(A)						
GdAB	1.9300	1.9300	1.9833	1.9833	1.8640	1.8640	1.9258
YAB	1.9157	1.9157	1.9586	1.9586	1.8565	1.8565	1.9102
LuAB	1.8794	1.8794	1.9480	1.9480	1.7572	1.7572	1.8615
(Lu _{0.6} Al _{0.4}) AB	1.8583	1.8583	1.9830	1.9830	1.7249	1.7249	1.8554



Fig. S1. Rietveld refinements of XRD patterns of LnAB:0.12Cr³⁺.



Fig. S2. Diffuse reflection spectra of LnAB:0.12Cr³⁺.



Fig. S3. Rietveld refinement of XRD pattern of (Lu_{0.6}Al_{0.4})AB:0.12Cr³⁺.



Fig. S4. PLE and PL spectra of $(Lu_{0.6}Al_{0.4})AB:0.12Cr^{3+}$.